Abstract

Recent developments in the field of high intensity electron beams in the regime below 10 MeV, e.g. energy recovery linacs or magnetized high energy electron coolers, have led to special demands on the beam diagnostics. Since commonly used diagnostic tools like synchrotron radiation and scintillation screens are ineffective or not able to withstand the beam power without being damaged, new methods are needed. Hence, a beam profile measurement system based on beam induced fluorescence (BIF) was built. This quite simple system images the light generated by the interaction of the beam with the residual gas onto a PMT. A more elaborated system, the Thomson Laser Scanner (TLS) — the non-relativistic version of the Laser Wire Scanner — is proposed as a method for non-invasive measurement of all phase space components, especially in the injector and merger parts of an ERL. Both methods are implemented in a 100 keV photo gun.

INTRODUCTION

High intensity electron beams are getting more and more popular. The new energy cooling devices easily reach several MWs of beam power. Because of energy recuperation in the collector, they allow only a very small beam loss, which is not compatible with normal destructive diagnostics. The energy recovery linac (ERL), the second type of high intensity electron beam machines, can make use of the emitted synchrotron radiation for profile measurement, but this is only possible after the main linac. In the injector and merger section, there is also the need for non-intercepting beam diagnostic devices.

There are already several non-destructive beam diagnostic methods established, which are used in different accelerators, such as a scintillation profile monitor [2] at COSY, [3] at GSI or the laser wire scanner at the synchrotron source PETRA III [4]. These methods can be adapted for the profile measurement of high intensity electron beams.

BEAM INDUCED FLUORESCENCE

For protons and ions, beam profile measurement based on beam induced fluorescence is a common technique [5]. The idea is to image the fluorescing residual gas on a photo detector with a spatial resolution. Instead of a detector with a spatial resolution, a photomultiplier tube (PMT) with a slit in front of it can be used. The slit cuts out a small slice of the electron beam image at the PMT as indicated in Fig. 1. By moving the slit up and down, a beam profile can be measured.

To measure the beam induced fluorescence, a new vacuum chamber has been installed at the polarized test source (PKAT) [7] shown in Fig. 2 at the Mainzer Mikrotron (MAMI). In this source, a NEA-GaAs [8] photo cathode is used, which requires a pressure much lower than 10^{-10} mbar for stable operation. Therefore, this chamber is separated from the cathode chamber by two differential pumping stages. The first one consists of a turbo molecular pump (purple) and the second one of two ion getter pumps (blue). This allows local pressure bumps of up to 10^{-5} mbar while maintaining the UHV condition at the cathode. These high pressures are necessary to achieve a significant amount of fluorescent light because the beam current of the photo gun is limited to a few 100 μA.
Table 1: BIF profile measurement conditions

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Value</th>
</tr>
</thead>
<tbody>
<tr>
<td>Beam energy</td>
<td>100 keV</td>
</tr>
<tr>
<td>Beam current</td>
<td>100 μA</td>
</tr>
<tr>
<td>Residual gas pressure</td>
<td>≈10⁻⁵ mbar</td>
</tr>
<tr>
<td>PMT voltage</td>
<td>1000 V</td>
</tr>
<tr>
<td>Slit width</td>
<td>0.2 mm</td>
</tr>
</tbody>
</table>

Figure 3: Beam profile measurement of the same beam but once displaced by 1.5 mm.

With this setup, first beam profiles have been measured. The conditions during the measurement are listed in Table 1.

A typical measurement is shown in Fig. 3. In this case the photo current of the PMT was amplified and measured vs. the slit position. It shows two measurements of the same beam, but for the second measurement the beam was steered by 1.5 mm with a small dipole magnet in front of the BIF chamber. A convolution of a Gaussian function and a slit function is fit with a least square fit to provide the beam size. Both fits result in beam widths which are the same within the error coming from the fit.

**THOMSON SCATTERING**

Thomson scattering describes elastic scattering of a photon on a free electron. It is the low energy limit of the Compton scattering process. Fig. 4 shows a schematic view of Thomson scattering.

A photon $\lambda_L$ hits the electron beam with an angle $\Theta$ and is scattered with the scattering angle $\Theta'$. The scattered photon $\lambda_S$ gains energy due to the Doppler shift. The wavelength of the scattered photon as a function of the angle between incident photon and electron and the angle between scattered photon and electron can be evaluated with

$$\lambda_S = \lambda_L \frac{(1 + \beta \cos \Theta')}{(1 + \beta \cos \Theta)} \quad (1)$$

where $\beta$ is the electron velocity in units of the speed of light. The scattering process is determined by the Thomson cross section

$$\frac{d\sigma}{d\Omega} = \frac{1}{2} r_e^2 \left(1 + \cos^2 \Theta'\right) \quad (2)$$

with $r_e$ = classical electron radius. The number of scattered photons can be calculated with the following equation

$$R = \frac{1}{2} r_e^2 \left(1 + \cos^2 (\Theta')\right) N_I n_e P e \Delta\Omega \frac{(1 + \beta \cos (\Theta))}{(1 + \beta \cos (\Theta'))} \epsilon \quad (3)$$

with $N_I$ = Number of incident photons per Joule, $n_e$ = Electron density, $P$ = laser power, $\epsilon$ = Detector system efficiency, $\Delta\Omega = $ Detector solid angle, $l = $ Interaction length, $[(1 + \beta \cos (\Theta))/((1 + \beta \cos (\Theta'))] = $ factor results from Lorentz transformation.

**Beam Diagnostics**

For our experiment, we are using the following angles $\Theta = 90^\circ$ and $\Theta' = 180^\circ$ like a laser wire scanner. In this case, the rate of the scattered photons only depends on the electron density in the electron beam. By moving the laser beam through the electron beam, a profile measurement can be done. Due to the low cross section, which is mostly dominated by the classical electron radius squared, the required laser power is very high. This was the reason why the pioneer experiment done in 1987/88 suffered from very low count rates [9], [10]. With the development in laser technology, it is now possible to achieve higher count rates, which makes this method interesting. In Table 2 the event rates for different setups are shown. For the calculation, a 100 W laser system and an electron beam current of 1 A and a diameter of 3 cm was chosen. The detector system efficiency is estimated to be $\epsilon = 0.2$ and solid angle $\Delta\Omega = 100$ msr.

Like the BIF measurements, the Thomson scattering experiment will also be done at the PKA T. Therefore, the

![Figure 4: Thomson scattering scheme.](image-url)

Table 2: Scattering Rate for Different Cooling Devices

<table>
<thead>
<tr>
<th>Beam energy</th>
<th>$\lambda_L/\mu m$</th>
<th>$\lambda_S/\mu m$</th>
<th>Event rate /s⁻¹</th>
</tr>
</thead>
<tbody>
<tr>
<td>100 keV (PKA T)</td>
<td>1.03</td>
<td>712</td>
<td>14</td>
</tr>
<tr>
<td>2 MeV (COSY)</td>
<td>10.6</td>
<td>220</td>
<td>$6.1 \cdot 10^2$</td>
</tr>
<tr>
<td>4.5 MeV (HESR)</td>
<td>10.6</td>
<td>50</td>
<td>$1.2 \cdot 10^3$</td>
</tr>
<tr>
<td>8 MeV (ENC)</td>
<td>10.6</td>
<td>20</td>
<td>$2.1 \cdot 10^3$</td>
</tr>
</tbody>
</table>
PKAT has been modified. Recently, these modifications have been carried out as shown in Fig. 5. The electrostatic deflector was replaced with an alpha magnet and a new TLS chamber was installed. This enables a detection of the scattered photons in forward direction while the electrons are bent by 270°. To focus the beam into the beam dump, a quadrupole doublet was also added to the beam line as well as new steering magnets. This should help to decrease the background created by beam losses at the wall of the vacuum chamber. To achieve the desired electron beam density for the event rates mentioned above, we need an electron beam with a current of 100 mA and a diameter of 3 mm.

The Laser System

The power supply of the PKAT is capable of delivering 3 mA of beam current so the required 100 mA can only be achieved in a pulsed mode. Therefore, a new laser system was purchased. It consists of a green laser to create the electron beam at the photo cathode and a IR laser for the Thomson scattering. The parameter of the laser system are shown in Tab. 3. In this case, a system with a high repetition frequency was chosen to lower the peak power of the laser to stay below the damage threshold of the different components, e.g. vacuum windows. This in combination with the pulse duration gives a duty cycle of \(2 \cdot 10^{-3}\), i.e. despite of the 100 mA peak current, the average beam current is only 200\(\mu\)A. This keeps the beam power low, and there is no need of a special beam dump capable of handling several kW of beam power. Since the count rate suffers from the low cross section of the Thomson scattering, the timing between electron and laser beam is essential for this experiment. If laser and electron beam are not synchronized very carefully, the count rate in the detector decreases enormously due to the low electron density or the lower number of photons in the scattering process. Therefore, a synchronization unit can delay one laser with respect to the other by up to 1000 ns in steps of 1 ns so the time the electrons need to travel from the source to the TLS-chamber can be compensated for.

OUTLOOK

To increase the dynamic range and the signal to noise ratio of the BIF measurements, a cooling system for the PMT will be installed. Also, a YAG screen was installed in the BIF chamber, and we are planning to do beam profile measurements with both methods to compare the results. It is also planned to use a detection system with a spatial resolution e.g. a ICCD camera.

The installation of both lasers including enclosure for safety issues should be finished shortly. It is planned to do some tests to investigate the background caused by beam loss and BIF. For beam profile measurements, a system which is able to displace the laser beam will be installed in the future.

REFERENCES